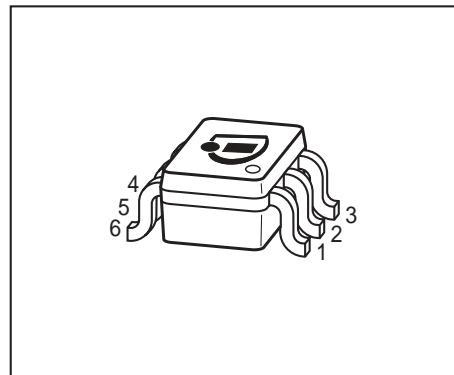


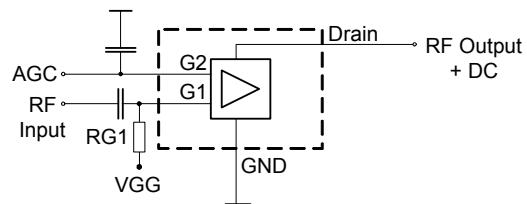
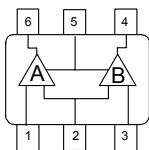
Dual N-Channel MOSFET Tetrode

Preliminary data

- Low noise gain controlled input stages for UHF and VHF -tuners e. g. (NTSC, PAL)
- Two AGC amplifiers in one single package
- Integrated gate protection diodes
- Low noise figure, high AGC-range
- Improved cross modulation at gain reduction
- G_{1A} and G_{1B} at same side
- Pb-free (RoHS compliant) package
- Qualified according AEC Q101



BG5120K



ESD (Electrostatic discharge) sensitive device, observe handling precaution!

Type	Package	Pin Configuration						Marking
BG5120K	SOT363	1=G1*	2=G2	3=G1**	4=D**	5=S	6=D*	K1

* For amp. A; ** for amp. B

180° rotated tape loading orientation available

Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-source voltage	V_{DS}	8	V
Continuous drain current	I_D	20	mA
Gate 1/ gate 2-source current	$\pm I_{G1/2SM}$	1	
Gate 1/ gate 2-source voltage	$\pm V_{G1/G2S}$	6	V
Total power dissipation	P_{tot}	200	mW
Storage temperature	T_{stg}	-55 ... 150	°C
Channel temperature	T_{ch}	150	

Thermal Resistance

Parameter	Symbol	Value	Unit
Channel - soldering point ¹⁾	R_{thchs}	≤ 280	K/W

¹⁾For calculation of R_{thJA} please refer to Application Note Thermal Resistance

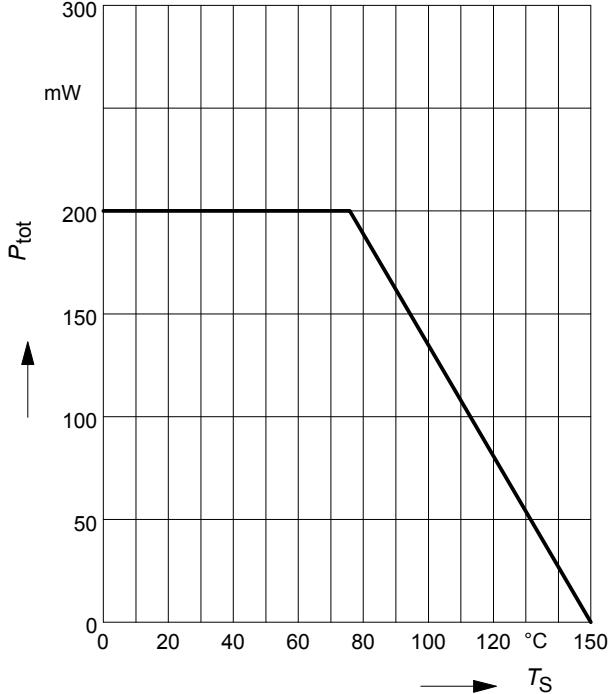
Electrical Characteristics at $T_A = 25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics					
Drain-source breakdown voltage $I_D = 10 \mu\text{A}, V_{G1S} = 0, V_{G2S} = 0$	$V_{(\text{BR})\text{DS}}$	12	-	-	V
Gate1-source breakdown voltage $+I_{G1S} = 10 \text{ mA}, V_{G2S} = 0, V_{\text{DS}} = 0$	$+V_{(\text{BR})\text{G1SS}}$	6	-	15	
Gate2-source breakdown voltage $+I_{G2S} = 10 \text{ mA}, V_{G1S} = 0, V_{\text{DS}} = 0$	$+V_{(\text{BR})\text{G2SS}}$	6	-	15	
Gate1-source leakage current $V_{G1S} = 6 \text{ V}, V_{G2S} = 0, V_{\text{DS}} = 0$	$+I_{\text{G1SS}}$	-	-	50	nA
Gate2-source leakage current $V_{G2S} = 6 \text{ V}, V_{G1S} = 0, V_{\text{DS}} = 0$	$+I_{\text{G2SS}}$	-	-	50	
Drain current $V_{\text{DS}} = 5 \text{ V}, V_{G1S} = 0, V_{G2S} = 4 \text{ V}$	I_{DSS}	-	-	1	μA
Drain-source current $V_{\text{DS}} = 5 \text{ V}, V_{G2S} = 4 \text{ V}, R_{\text{G1}} = 150 \text{ k}\Omega$	I_{DSX}	-	12	-	mA
Gate1-source pinch-off voltage $V_{\text{DS}} = 5 \text{ V}, V_{G2S} = 4 \text{ V}, I_D = 20 \mu\text{A}$	$V_{\text{G1S(p)}}$	-	0.7	-	V
Gate2-source pinch-off voltage $V_{\text{DS}} = 5 \text{ V}, I_D = 20 \mu\text{A}, V_{G1S} = 2 \text{ V}$	$V_{\text{G2S(p)}}$	-	0.6	-	

Electrical Characteristics at $T_A = 25^\circ\text{C}$, unless otherwise specified

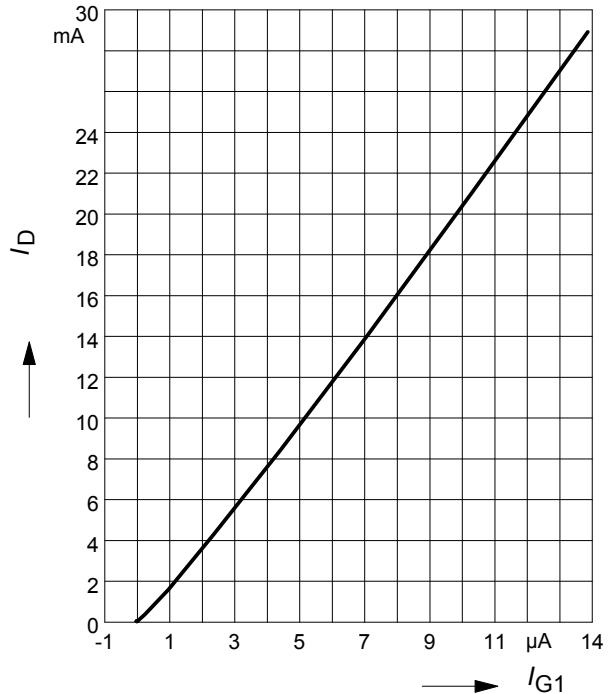
Parameter	Symbol	Values			Unit
		min.	typ.	max.	
AC Characteristics $V_{DS} = 5\text{V}$, $V_{G2S} = 4\text{V}$, ($I_D = 10\text{mA}$) (verified by random sampling)					
Forward transconductance	g_{fs}	-	33	-	mS
Gate1 input capacitance	C_{g1ss}	-	2.2	-	pF
Output capacitance	C_{dss}	-	1.3	-	
Power gain 800 MHz 45 MHz	G_p	-	24	-	dB
		-	33	-	
Noise figure 800 MHz 45 MHz	F	-	1.2	-	dB
		-	0.8	-	
Gain control range	ΔG_p	45	-	-	
Cross-modulation $k=1\%$, $f_W=50\text{MHz}$, $f_{unw}=60\text{MHz}$ AGC = 0 dB AGC = 10 dB AGC = 40 dB	X_{mod}	90	-	-	dB μ V
		-	95	-	
		100	105	-	

Total power dissipation $P_{\text{tot}} = f(T_S)$



Drain current $I_D = f(I_{G1})$

$V_{G2S} = 4V$

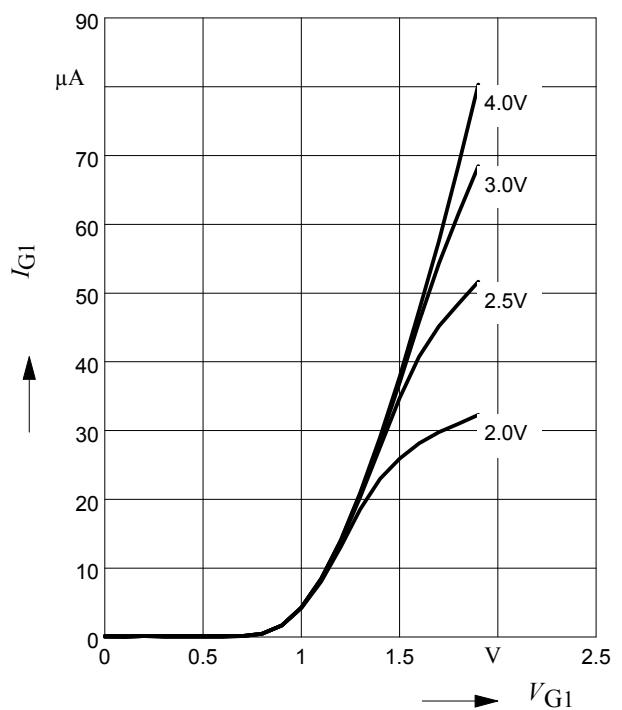
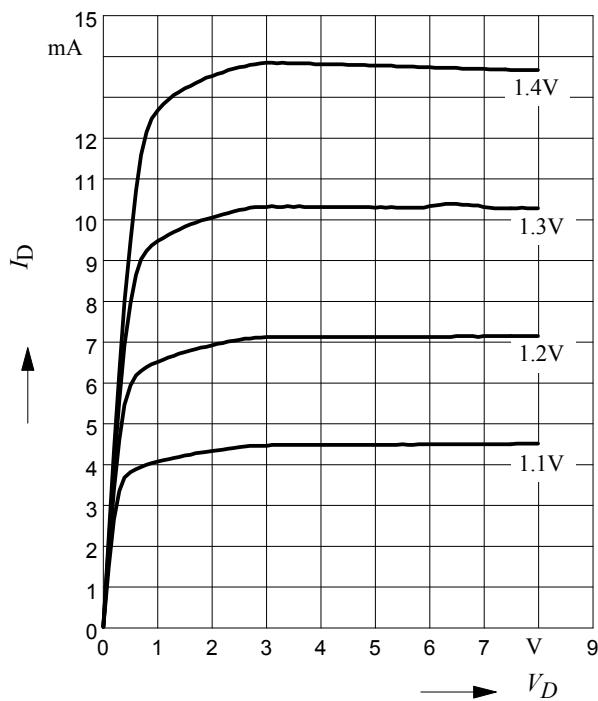


Output characteristics $I_D = f(V_{DS})$

Gate 1 current $I_{G1} = f(V_{G1S})$

$V_{DS} = 5V$

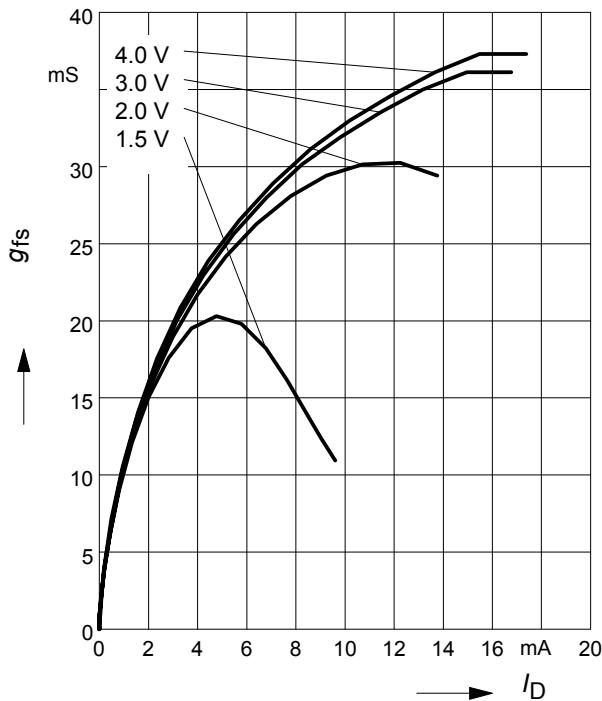
$V_{G2S} = \text{Parameter}$



Gate 1 forward transconductance

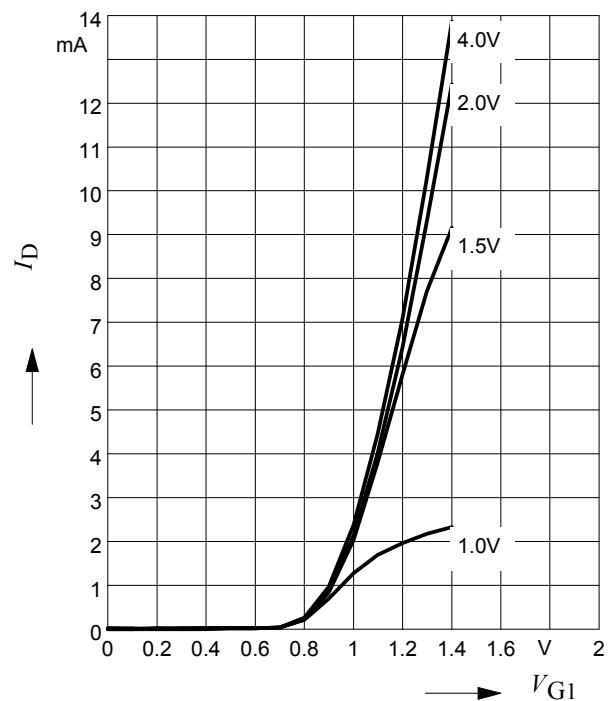
$$g_{fs} = f(I_D)$$

$V_{DS} = 5V$, V_{G2S} = Parameter


Drain current $I_D = f(V_{G1S})$

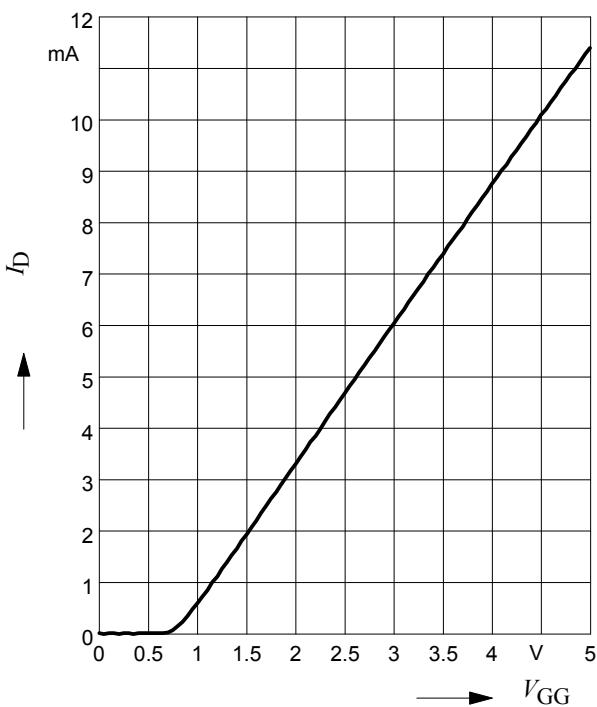
$$V_{DS} = 5V$$

V_{G2S} = Parameter


Drain current $I_D = f(V_{GG})$

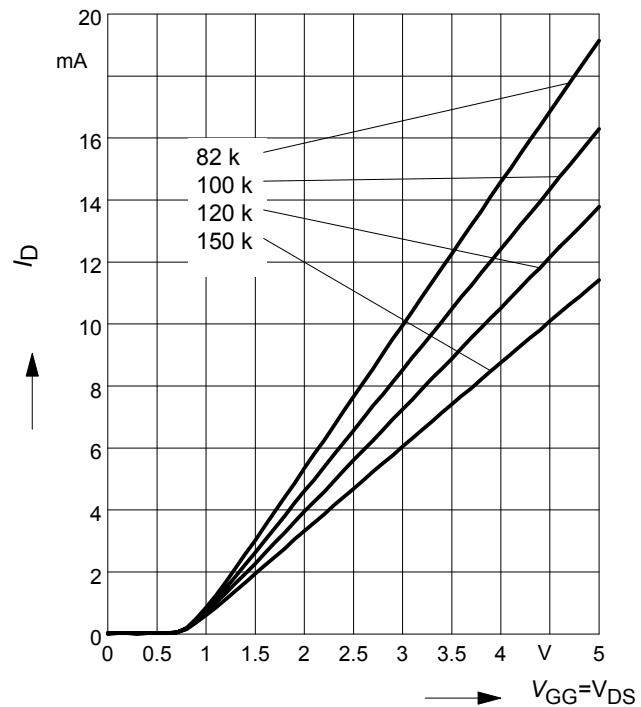
$$V_{DS} = 5V, V_{G2S} = 4V, R_{G1} = 150k\Omega$$

(connected to V_{GG} , V_{GG} =gate1 supply voltage)

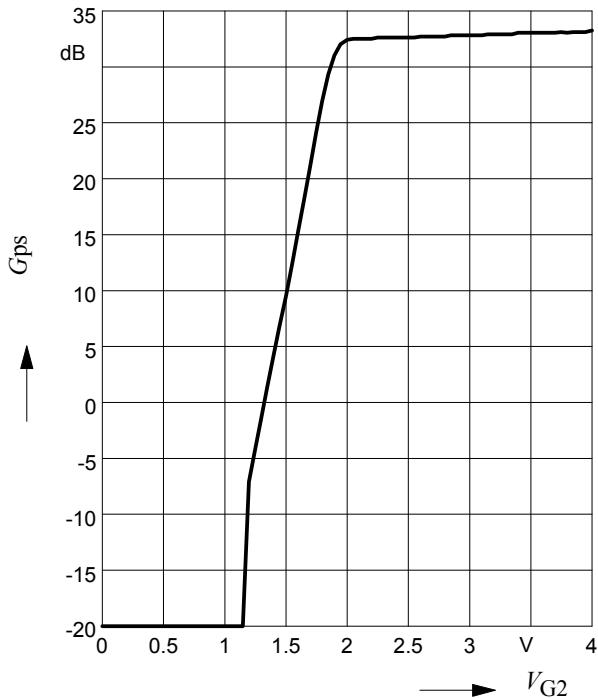

Drain current $I_D = f(V_{GG})$

$$V_{DS} = 5V, V_{G2S} = 4V$$

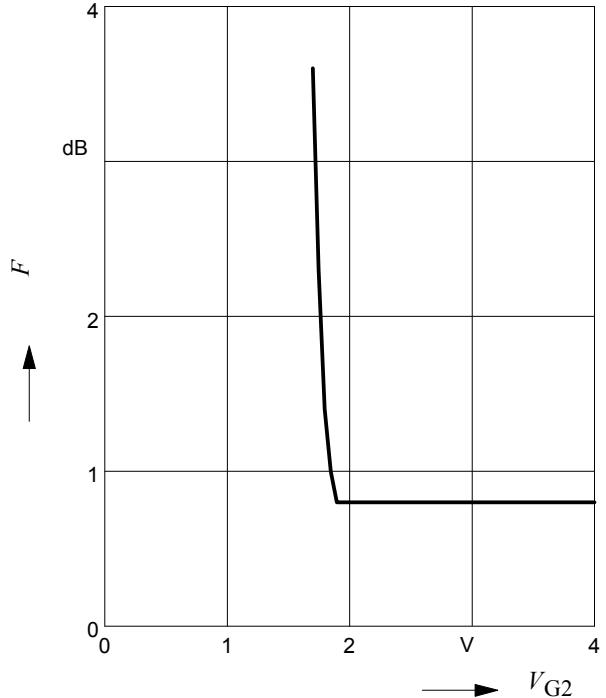
R_{G1} = Parameter in k Ω



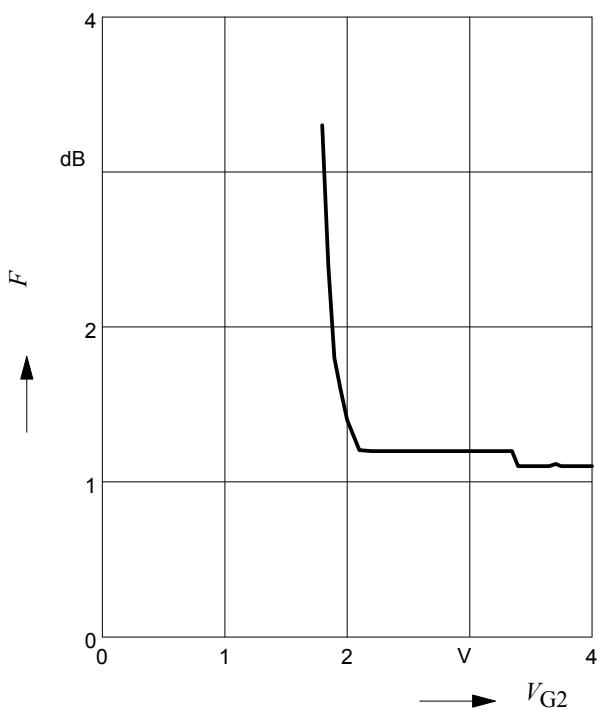
Power gain $G_{ps} = f(V_{G2S})$
 $f = 45\text{MHz}$



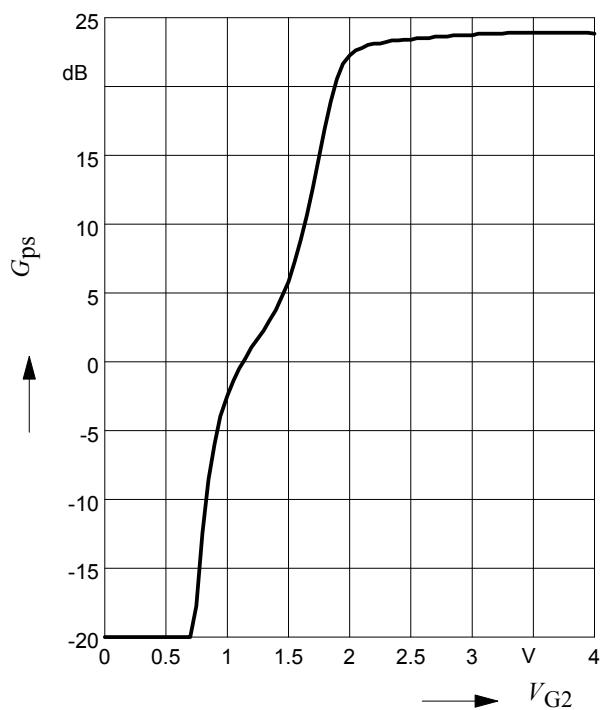
Noise figure $F = f(V_{G2S})$
 $f = 45\text{MHz}$



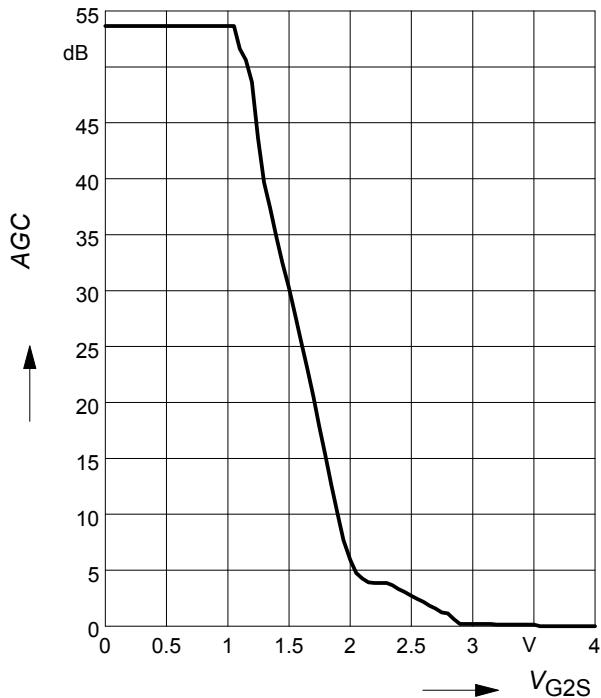
Noise figure $F = f(V_{G2S})$
 $f = 800\text{MHz}$



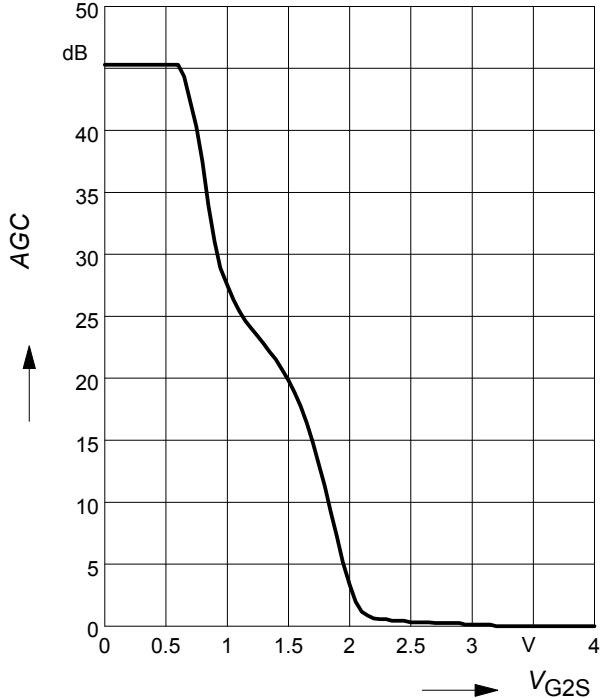
Power gain $G_{ps} = f(V_{G2S})$
 $f = 800 \text{ GHz}$



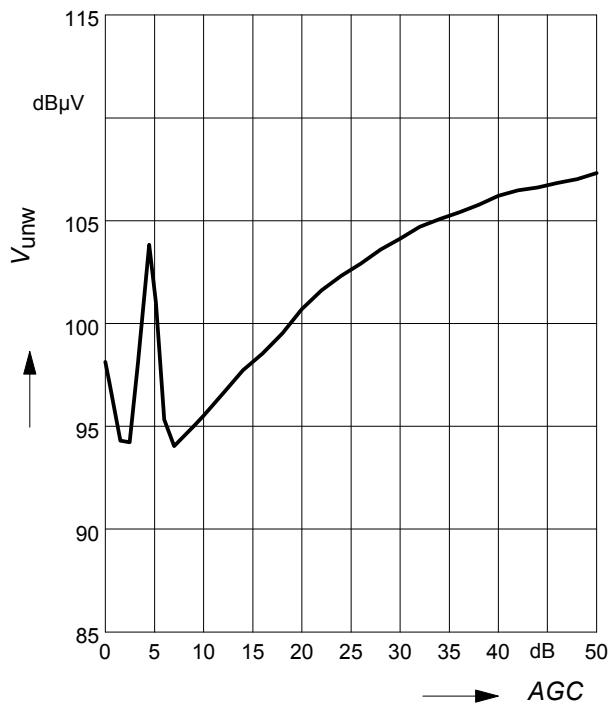
AGC characteristic $AGC = f(V_{G2S})$
 $V_{DS} = 5 \text{ V}$, $R_{GG} = 120 \text{ k}\Omega$, $f = 45 \text{ MHz}$

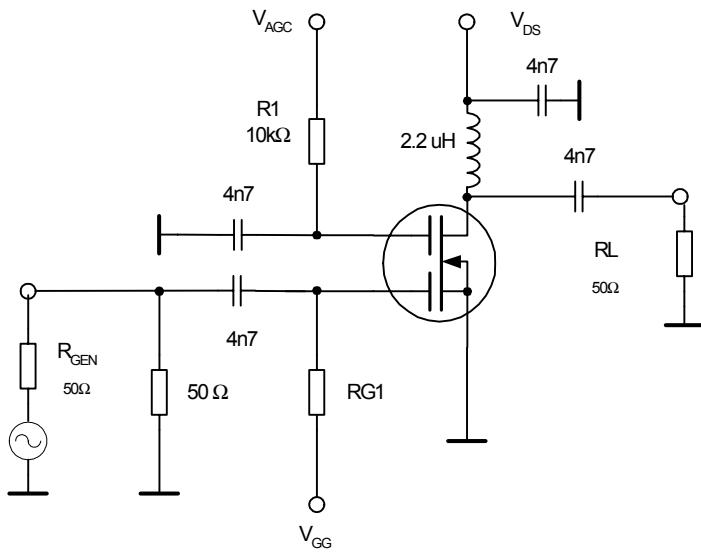


AGC characteristic $AGC = f(V_{G2S})$
 $V_{DS} = 5 \text{ V}$, $R_{GG} = 120 \text{ k}\Omega$, $f = 800 \text{ MHz}$



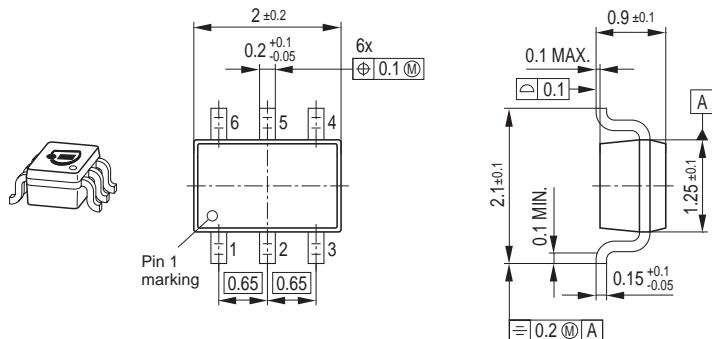
Crossmodulation $V_{unw} = (AGC)$
 $V_{DS} = 5 \text{ V}$, $I_D = 14 \text{ mA}$



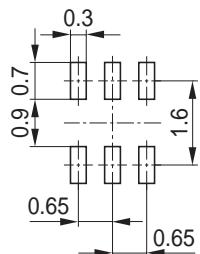
Crossmodulation test circuit


Semibiased

Package Outline

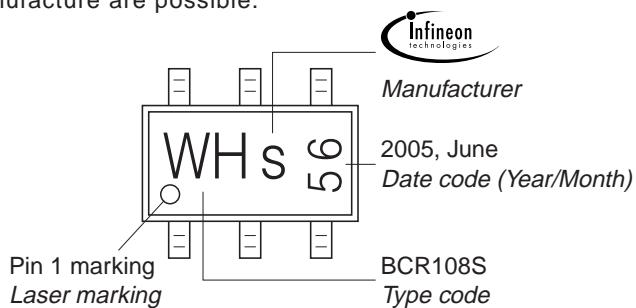


Foot Print



Marking Layout (Example)

Small variations in positioning of Date code, Type code and Manufacture are possible.

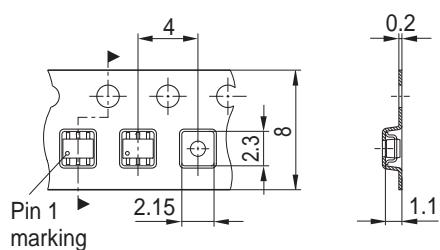


Standard Packing

Reel $\varnothing 180$ mm = 3.000 Pieces/Reel

Reel $\varnothing 330$ mm = 10.000 Pieces/Reel

For symmetric types no defined Pin 1 orientation in reel.



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